

Field Stop Trench IGBT

50 A, 650 V

AFGHL50T65SQD

Using the novel field stop 4th generation high speed IGBT technology. AFGHL50T65SQD which is AEC Q101 qualified offers the optimum performance for both hard and soft switching topology in automotive application.

Features

- AEC-Q101 Qualified
- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(Sat)} = 1.6 \text{ V (Typ.)} @ I_C = 50 \text{ A}$
- 100% of the Parts are Tested for I_{LM} (Note 2)
- Fast Switching
- Tight Parameter Distribution
- RoHS Compliant

Typical Applications

- Automotive HEV–EV Onboard Chargers
- Automotive HEV-EV DC-DC Converters
- Totem Pole Bridgeless PFC
- PTC

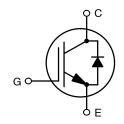
MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-to-Emitter Voltage	V _{CES}	650	V
Gate-to-Emitter Voltage Transient Gate-to-Emitter Voltage	V _{GES}	±20 ±30	V
Collector Current (Note 1) @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	IC	80 50	Α
Pulsed Collector Current (Note 2)	I _{LM}	200	Α
Pulsed Collector Current (Note 3)	I _{CM}	200	Α
Diode Forward Current (Note 1) @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	I _F	80 30	Α
Pulsed Diode Maximum Forward Current	I _{FM}	200	Α
Maximum Power Dissipation @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	P _D	268 134	W
Operating Junction / Storage Temperature Range	T _J , T _{STG}	–55 to +175	°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

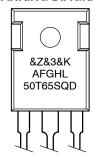
- 1. Value limit by bond wire
- 2. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} = 200 A, R_{G} = 15 Ω , Inductive Load
- 3. Repetitive Rating: pulse width limited by max. Junction temperature

50 A, 650 V, V_{CESat} = 1.6 V





MARKING DIAGRAM



&Z = Assembly Plant Code &3 = 3-Digit Date Code &K = 2-Digit Lot Traceability Code AFGHL50T65SQD = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
AFGHL50T65SQD	TO-247-3L	30 Units / Rail

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ heta JC}$	0.56	°C/W
Thermal resistance junction-to-case, for Diode	$R_{ heta JC}$	1.25	°C/W
Thermal resistance junction-to-ambient	$R_{ heta JA}$	40	°C/W

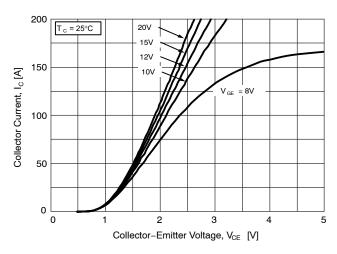
ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS			•		•	
Collector-emitter breakdown voltage, gate-emitter short-circuited	V _{GE} = 0 V, I _C = 1 mA	BV _{CES}	650	-	-	V
Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	ΔBV _{CES} ΔT _J	-	0.6	-	V/°C
Collector-emitter cut-off current, gate-emitter short-circuited	V _{GE} = 0 V, V _{CE} = 650 V	I _{CES}	-	-	250	μΑ
Gate leakage current, collector- emitter short-circuited	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	-	-	±400	nA
ON CHARACTERISTICS						
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 50 \text{ mA}$	V _{GE(th)}	3.4	4.9	6.4	V
Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 50 A V _{GE} = 15 V, I _C = 50 A, T _J = 175°C	V _{CE(sat)}	-	1.6 1.95	2.1 -	V
DYNAMIC CHARACTERISTICS			•	•		
Input capacitance	V _{CE} = 30 V,	C _{ies}	-	3258	_	pF
Output capacitance	V _{GE} = 0 V, f = 1 MHz	C _{oes}	-	85	-	
Reverse transfer capacitance		C _{res}	-	11	-	
Gate charge total	V _{CE} = 400 V,	Q_g	-	102	-	nC
Gate-to-emitter charge	I _C = 50 A, V _{GE} = 15 V	Q _{ge}	-	18	-	
Gate-to-collector charge		Q_{gc}	-	24	-	
SWITCHING CHARACTERISTICS, INC	DUCTIVE LOAD					
Turn-on delay time	$T_{\rm C} = 25^{\circ}{\rm C},$	t _{d(on)}	-	19	-	ns
Rise time	$V_{CC} = 400 \text{ V},$ $I_{C} = 25 \text{ A},$	t _r	-	11	-	
Turn-off delay time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$,	t _{d(off)}	-	87	-	
Fall time	Inductive Load	t _f	-	5	-	
Turn-on switching loss		E _{on}	-	0.35	-	mJ
Turn-off switching loss		E _{off}	-	0.12	-	
Total switching loss	1	E _{ts}	-	0.47	-	
Turn-on delay time	T _C = 25°C,	t _{d(on)}	-	20	-	ns
Rise time	$V_{CC} = 400 \text{ V},$ $I_{C} = 50 \text{ A},$	t _r	-	28	-	
Turn-off delay time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$,	t _{d(off)}	-	81	-	
Fall time	Inductive Load	t _f	-	36	-	
Turn-on switching loss	1	E _{on}	-	0.95	-	mJ
Turn-off switching loss	1	E _{off}	-	0.46	-	
Total switching loss	1	E _{ts}	-	1.41	-	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (Continued)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS, IN	DUCTIVE LOAD		•		•	
Turn-on delay time	T _C = 175°C,	t _{d(on)}	_	18	-	ns
Rise time	$V_{CC} = 400 \text{ V},$ $I_{C} = 25 \text{ A},$	t _r	-	14	-]
Turn-off delay time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$,	t _{d(off)}	-	99	-]
Fall time	Inductive Load	t _f	-	7	-	
Turn-on switching loss		E _{on}	-	0.66	-	mJ
Turn-off switching loss		E _{off}	-	0.3	-	
Total switching loss		E _{ts}	-	0.96	-]
Turn-on delay time	T _C = 175°C,	t _{d(on)}	-	20	-	ns
Rise time	$V_{CC} = 400 \text{ V},$ $I_{C} = 50 \text{ A},$	t _r	-	29	-]
Turn-off delay time	$R_G = 4.7 \Omega$, $V_{GE} = 15 V$,	t _{d(off)}	-	88	-]
Fall time	Inductive Load	t _f	-	46	-]
Turn-on switching loss		E _{on}	-	1.42	-	mJ
Turn-off switching loss		E _{off}	-	0.65	-]
Total switching loss		E _{ts}	-	2.07	-	
DIODE CHARACTERISTIC		•	-		•	
Diode Forward Voltage	I _F = 30 A, T _C = 25°C	V_{FM}	_	2.0	2.6	V
	I _F = 30 A, T _C = 175°C	1	_	1.7	-	1
Reverse Recovery Energy	$I_F = 30 \text{ A}, \text{ dI}_F/\text{dt} = 200 \text{ A}/\mu\text{s}, \\ T_C = 175^{\circ}\text{C}$	E _{rec}	-	50	_	μJ
Diode Reverse Recovery Time	$I_F = 30 \text{ A, } dI_F/dt = 200 \text{ A/μs},$ $T_C = 25^{\circ}\text{C}$	T _{rr}	_	30	_	ns
	$I_F = 30 \text{ A, } dI_F/dt = 200 \text{ A/}\mu\text{s,} $ $T_C = 175^{\circ}\text{C}$		_	194	_	
Diode Reverse Recovery Charge	I_F = 30 A, dI_F/dt = 200 A/ μ s, T_C = 25°C	Q _{rr}	-	42	_	nC
	$I_F = 30 \text{ A}, \text{ d}I_F/\text{d}t = 200 \text{ A}/\mu\text{s}, \\ T_C = 175^{\circ}\text{C}$		-	723	_	

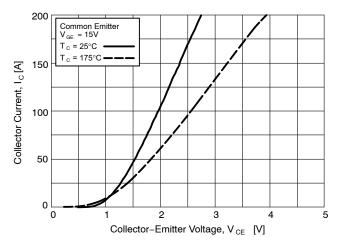
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



200 T_C = 175°C 20V 15V 15V 12V 12V 12V 12V 10V 0SE = 8V Collector–Emitter Voltage, V_{CE} [V]

Figure 1. Typical Output Characteristics

Figure 2. Typical Output Characteristics



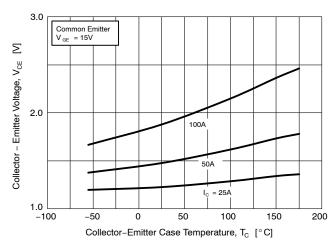
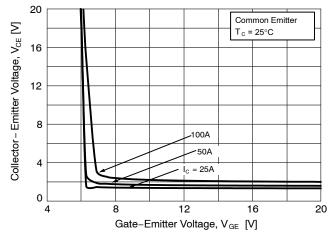


Figure 3. Typical Saturation Voltage

Figure 4. Saturation Voltage vs. Case Temperature



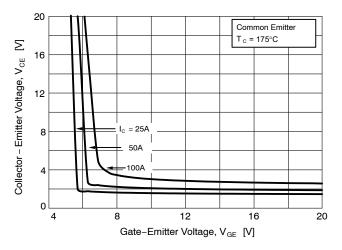


Figure 5. Saturation Voltage vs. V_{GE}

Figure 6. Saturation Voltage vs. V_{GE}

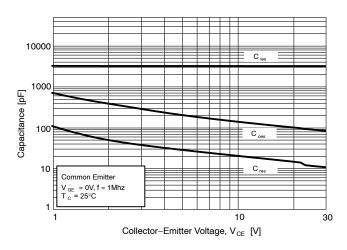
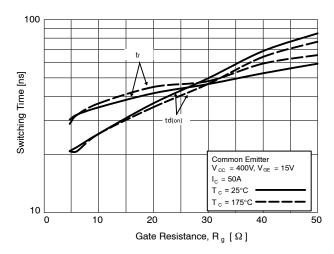


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge



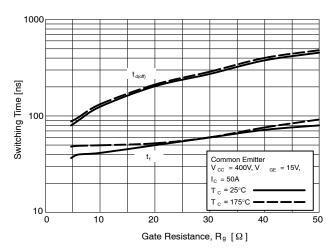
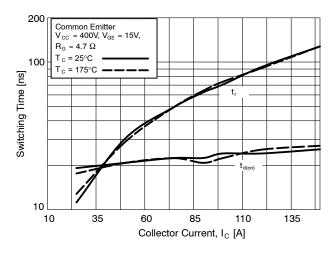


Figure 9. Turn-On Characteristics vs. Gate Resistance

Figure 10. Turn-Off Characteristics vs. Gate Resistance



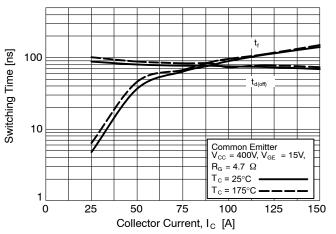
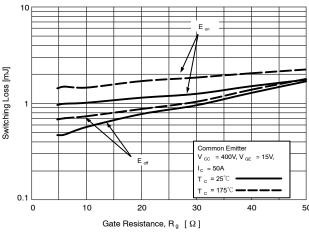


Figure 11. Turn-On Characteristics vs.
Collector Current

Figure 12. Turn-Off Characteristics vs.
Collector Current



0.1 50 0

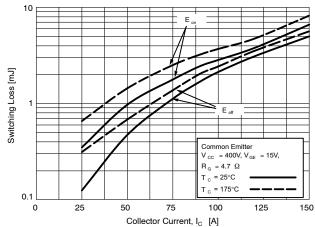
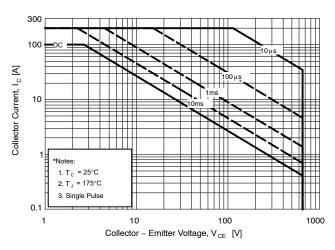


Figure 13. Switching Loss vs. Gate Resistance





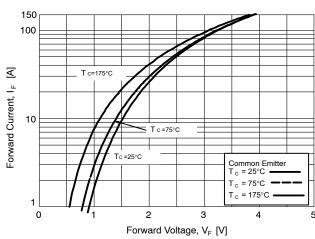


Figure 15. SOA Characteristics

Figure 16. Forward Characteristics

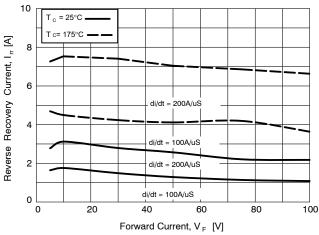


Figure 17. Reverse Recovery Current

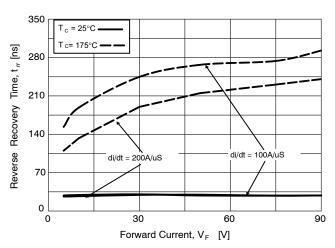


Figure 18. Reverse Recovery Time

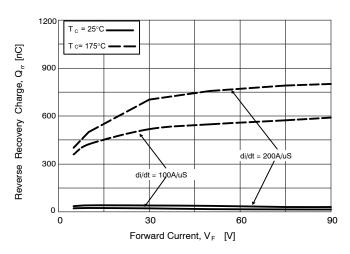


Figure 19. Stored Charge

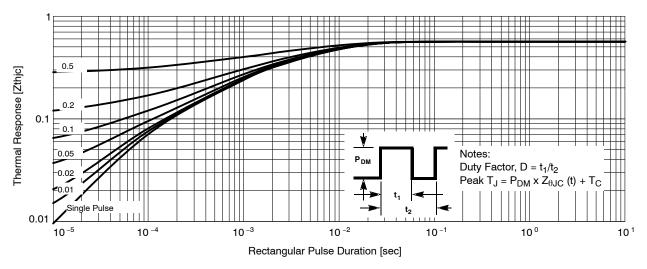


Figure 20. Transient Thermal Impedance of IGBT

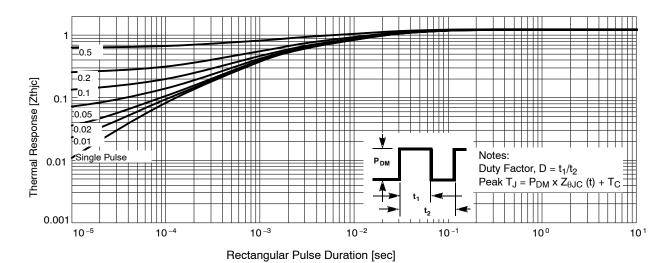
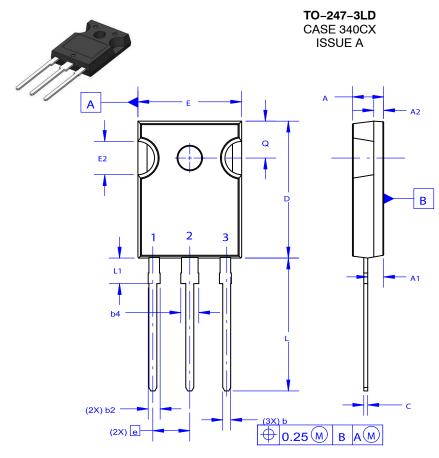


Figure 21. Transient Thermal Impedance of Diode

DATE 06 JUL 2020





NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week

WW = Work Week
G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

Ø _P —		Φ _{P1} D2
E1 —	2	D1

DIM	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	4.58	4.70	4.82	
A 1	2.20	2.40	2.60	
A2	1.40	1.50	1.60	
D	20.32	20.57	20.82	
Е	15.37	15.62	15.87	
E2	4.96	5.08	5.20	
е	~	5.56	~	
L	19.75	20.00	20.25	
L1	3.69	3.81	3.93	
ØΡ	3.51	3.58	3.65	
Q	5.34	5.46	5.58	
S	5.34	5.46	5.58	
b	1.17	1.26	1.35	
b2	1.53	1.65	1.77	
b4	2.42	2.54	2.66	
С	0.51	0.61	0.71	
D1	13.08	~	~	
D2	0.51	0.93	1.35	
E1	12.81	~	~	
ØP1	6.60	6.80	7.00	

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